

**Search Notes**

Application/Control No.

10/712,347

Examiner

Phu K. Nguyen

Applicant(s)/Patent under  
Reexamination

KAMIYAMA, NAOYA

Art Unit

2628

**SEARCHED**

Class	Subclass	Date	Examiner
345	440	5/20/2006	PN
	619	5/20/2006	PN
702	67	5/20/2006	PN
	68	5/20/2006	PN
update	search	1/19/2007	PN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
345	440	1/19/2007	
702	67	1/19/2007	
	68	1/19/2007	

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
WEST search waveform, oscilloscope, editor)	5/20/2006	PN
Nonpatent Literature (IEEE, ACM) search waveform, oscilloscope, editor)	5/20/2006	PN
Inventor Name search	5/20/2006	PN
Update searches (WEST, IEEE, ACM)	1/19/2007	PN